

Product Bulletin Document #: PB22152X

Document #: PB22152X Issue Date: 2 February 2018

Title of Change:	KAF-16801 datasheet update: Correction of errors induced by incorrect copy/paste actions.		
Effective date:	2 February 2018		
Contact information:	Contact your local ON Semiconductor Sales Office or < <u>John.Frenett@onsemi.com</u> >		
Type of notification:	This Product Bulletin is for notification purposes only. ON Semiconductor will proceed with implementation of this change upon publication of this Product Bulletin.		
Change category:	Wafer Fab Change Assembly Change	☐ Test Change ☐ Other <u>Documentation</u>	
Change Sub-Category(s): Manufacturing Site Change/A Manufacturing Process Chan		☐ Datasheet/Product Doc change ☐ Shipping/Packaging/Marking ☐ Other:	
Sites Affected:	ON Semiconductor Sites: ON Rochester, New York	External Foundry/Subcon Sites: None	
Description and Purpose:			
 Table 9 (CLOCK LEVELS) has been updated, as follows: a. Nominal value for Horizontal CCD Clock – Phase 1 was 2.0 V; now reads 8.0 V b. Nominal value for Horizontal CCD Clock – Phase 2 was 2.0 V; now reads 8.0 V The change will not impact form, fit, or function of KAF-16801 image sensors. 			
List of Affected Standard Parts:			
KAF-16801-AAA-DP-AE KAF-16801-AAA-DP-B1 KAF-16801-AAA-DP-B2			

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Appendix A: Changed Products

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Product	Customer Part Number	
KAF-16801-AAA-DP-B1		
KAF-16801-AAA-DP-B2		